

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination ONO ET AL.	
		10/051,185	Examiner	Art Unit
		Thoi V Duong	2871	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
	B	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	US 2002/0024627 A1, Sakamoto et al., Feb. 28, 2002
	V	
	W	
	X	

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